



RF Power Field Effect Transistors

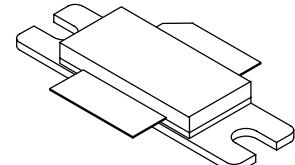
N-Channel Enhancement-Mode Lateral MOSFETs

Designed for PCN and PCS base station applications with frequencies from 2100 to 2200 MHz. Suitable for W-CDMA, CDMA, TDMA, GSM and multicarrier amplifier applications.

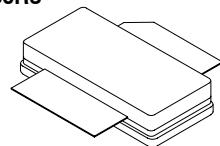
- Typical W-CDMA Performance: 2140 MHz, 28 Volts
5 MHz Offset @ 4.096 MHz BW, 15 DTCH
Output Power — 6.0 Watts
Power Gain — 12.5 dB
Drain Efficiency — 15%
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 28 Vdc, 2110 MHz, 60 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 Inch Reel.

MRF21060R3
MRF21060SR3

2170 MHz, 60 W, 28 V
LATERAL N-CHANNEL
RF POWER MOSFETs



CASE 465-06, STYLE 1
NI-780
MRF21060R3



CASE 465A-06, STYLE 1
NI-780S
MRF21060SR3

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|---|------------------|-------------|-----------|
| Drain-Source Voltage | V _{DSS} | -0.5, +65 | Vdc |
| Gate-Source Voltage | V _{GS} | -0.5, +15 | Vdc |
| Total Device Dissipation @ T _C = 25°C Derate above 25°C | P _D | 180 0.98 | W W/°C |
| Storage Temperature Range | T _{stg} | -65 to +150 | °C |
| Operating Junction Temperature | T _J | 200 | °C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--------------------------------------|------------------|-------|------|
| Thermal Resistance, Junction to Case | R _{θJC} | 1.02 | °C/W |

Table 3. ESD Protection Characteristics

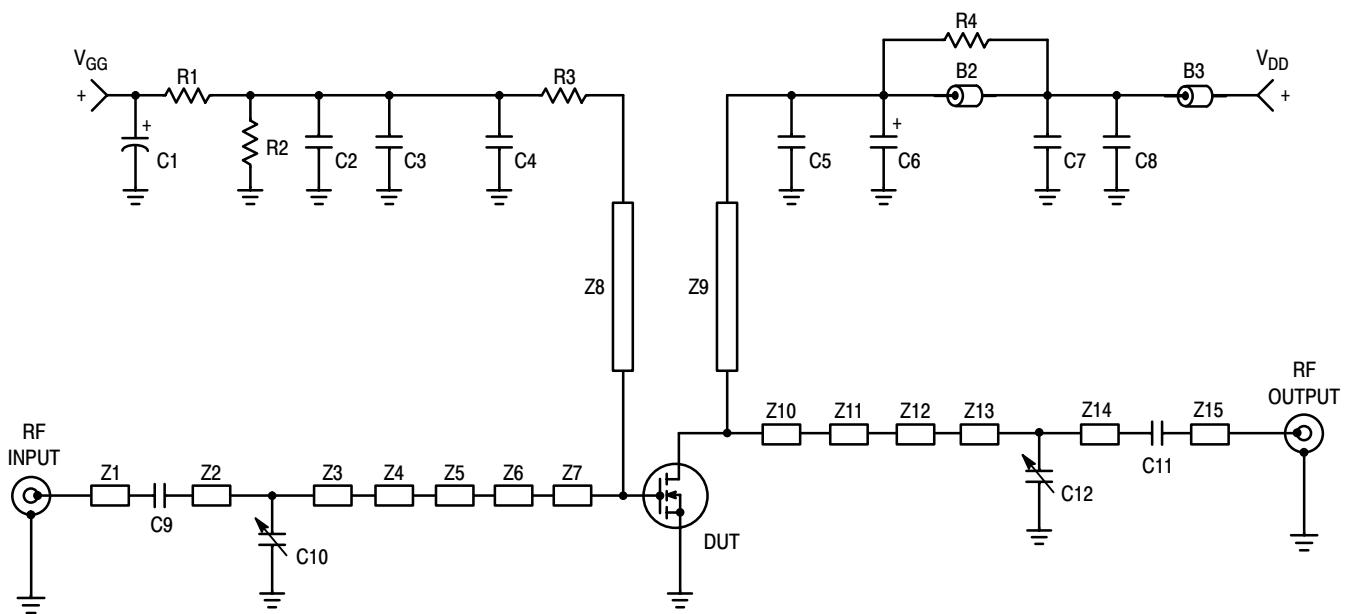
| Test Conditions | Class |
|------------------|--------------|
| Human Body Model | 2 (Minimum) |
| Machine Model | M3 (Minimum) |

NOTE - **CAUTION** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

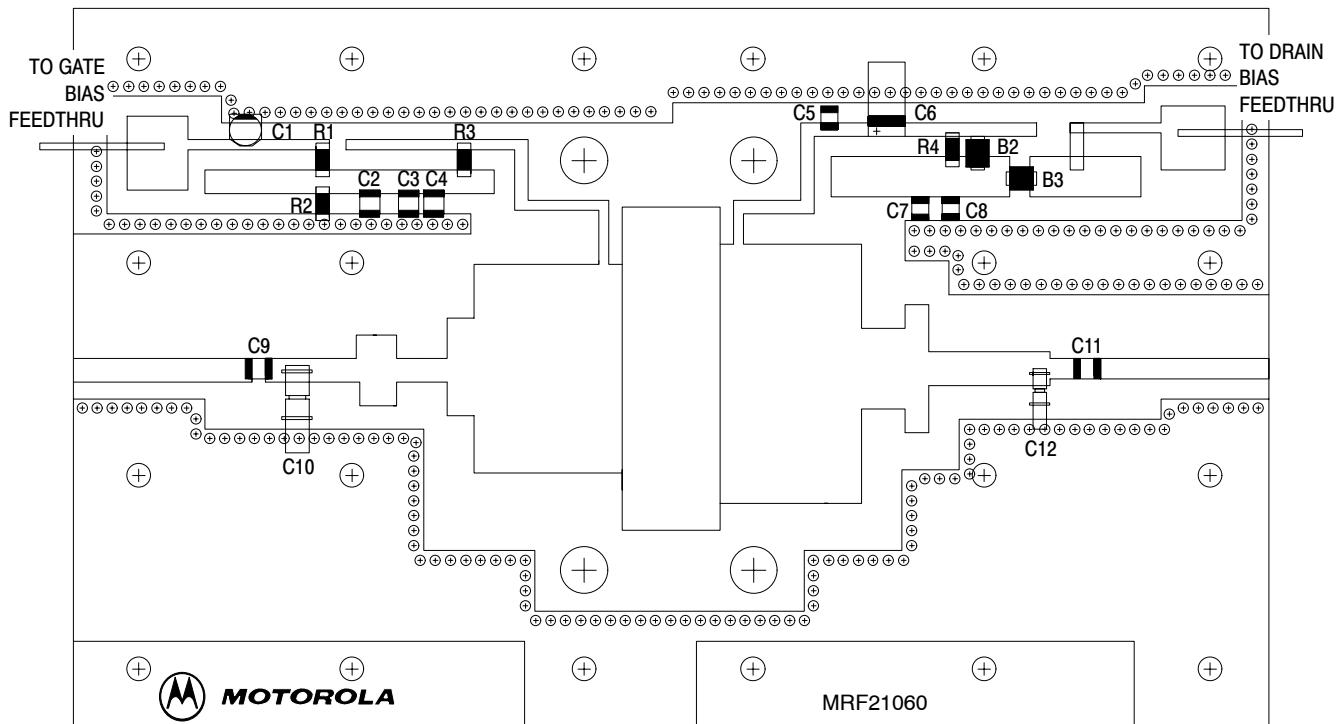
| Characteristic | Symbol | Min | Typ | Max | Unit |
|--|---------------------|---|------|-----|---------------|
| Off Characteristics | | | | | |
| Drain-Source Breakdown Voltage ($V_{GS} = 0 \text{ Vdc}$, $I_D = 10 \mu\text{A}$) | $V_{(BR)DSS}$ | 65 | — | — | Vdc |
| Zero Gate Voltage Drain Current ($V_{DS} = 28 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$) | I_{DSS} | — | — | 6 | μA |
| Gate-Source Leakage Current ($V_{GS} = 5 \text{ Vdc}$, $V_{DS} = 0 \text{ Vdc}$) | I_{GSS} | — | — | 1 | μA |
| On Characteristics | | | | | |
| Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}$, $I_D = 300 \mu\text{A}$) | $V_{GS(\text{th})}$ | 2 | — | 4 | Vdc |
| Gate Quiescent Voltage ($V_{DS} = 28 \text{ Vdc}$, $I_D = 500 \text{ mA}$) | $V_{GS(Q)}$ | 2.5 | 3.9 | 4.5 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10 \text{ Vdc}$, $I_D = 2 \text{ Adc}$) | $V_{DS(\text{on})}$ | — | 0.27 | — | Vdc |
| Forward Transconductance ($V_{DS} = 10 \text{ Vdc}$, $I_D = 2 \text{ Adc}$) | g_{fs} | — | 4.7 | — | S |
| Dynamic Characteristics | | | | | |
| Reverse Transfer Capacitance (1) ($V_{DS} = 28 \text{ Vdc}$, $V_{GS} = 0$, $f = 1 \text{ MHz}$) | C_{rss} | — | 2.7 | — | pF |
| Functional Tests (In Freescale Test Fixture, 50 ohm system) | | | | | |
| Two-Tone Common-Source Amplifier Power Gain ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W PEP}$, $I_{DQ} = 500 \text{ mA}$, $f = 2110 \text{ MHz}$ and 2170 MHz , Tone Spacing = 100 kHz) | G_{ps} | 11 | 12.5 | — | dB |
| Two-Tone Drain Efficiency ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W PEP}$, $I_{DQ} = 500 \text{ mA}$, $f = 2110 \text{ MHz}$ and 2170 MHz , Tone Spacing = 100 kHz) | η | 31 | 34 | — | % |
| 3rd Order Intermodulation Distortion ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W PEP}$, $I_{DQ} = 500 \text{ mA}$, $f = 2110 \text{ MHz}$ and 2170 MHz , Tone Spacing = 100 kHz) | IMD | — | -30 | -28 | dBc |
| Input Return Loss ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W PEP}$, $I_{DQ} = 500 \text{ mA}$, $f = 2110 \text{ MHz}$ and 2170 MHz , Tone Spacing = 100 kHz) | IRL | — | -12 | — | dB |
| $P_{out, 1 \text{ dB}}$ Compression Point ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W CW}$, $f = 2170 \text{ MHz}$) | $P_{1\text{dB}}$ | — | 60 | — | W |
| Output Mismatch Stress ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 60 \text{ W CW}$, $I_{DQ} = 500 \text{ mA}$, $f = 2110 \text{ MHz}$, VSWR = 10:1, All Phase Angles at Frequency of Tests) | Ψ | No Degradation In Output Power Before and After Test | | | |

1. Part is internally matched both on input and output.



| | | | |
|---------|--|-------|--|
| B2 - B3 | Ferrite Beads, Fair Rite #2743019447 | Z3 | 0.180" x 0.100" Microstrip |
| C1 | 10 μ F, 50 V Electrolytic Chip Capacitor, Panasonic #ECEV1HV100R | Z4 | 0.152" x 0.293" Microstrip |
| C2, C7 | 1000 pF Chip Capacitors, ATC #100B102JCA500X | Z5 | 0.216" x 0.100" Microstrip |
| C3, C8 | 0.10 μ F Chip Capacitors, Kemet #CDR33BX104AKWS | Z6 | 0.114" x 0.410" Microstrip |
| C4, C5 | 4.7 pF Chip Capacitors, ATC #100B4R7JCA500X | Z7 | 0.626" x 0.872" Microstrip |
| C6 | 22 μ F, 35 V Tantalum Surface Mount Chip Capacitor, Sprague | Z8 | 1.050" x 0.050" Microstrip |
| C9, C11 | 9.1 pF Chip Capacitors, ATC #100B9R1JCA500X | Z9 | 0.830" x 0.050" Microstrip |
| C10 | 0.8 pF - 8.0 pF Variable Capacitor, Johanson Gigatrim | Z10 | 0.596" x 1.040" Microstrip |
| C12 | 0.4 pF - 4.5 pF Variable Capacitor, Johanson Gigatrim | Z11 | 0.186" x 0.315" Microstrip |
| R1 | 1 k Ω , 1/4 W Fixed Film Chip Resistor, 0.08" x 0.13" | Z12 | 0.097" x 0.525" Microstrip |
| R2 | 560 k Ω , 1/4 W Fixed Film Chip Resistor, 0.08" x 0.13" | Z13 | 0.353" x 0.138" Microstrip |
| R3 | 10 Ω , 1/4 W Fixed Film Chip Resistor, 0.08" x 0.13" | Z14 | 0.112" x 0.080" Microstrip |
| R4 | 10 Ω , 1/4 W Fixed Film Chip Resistor, 0.08" x 0.13" | Z15 | 0.722" x 0.080" Microstrip |
| Z1 | 0.743" x 0.080" Microstrip | Board | 0.030" Glass Teflon®, Arlon GX-0300-55-22, 2 oz Cu |
| Z2 | 0.070" x 0.100" Microstrip | | |

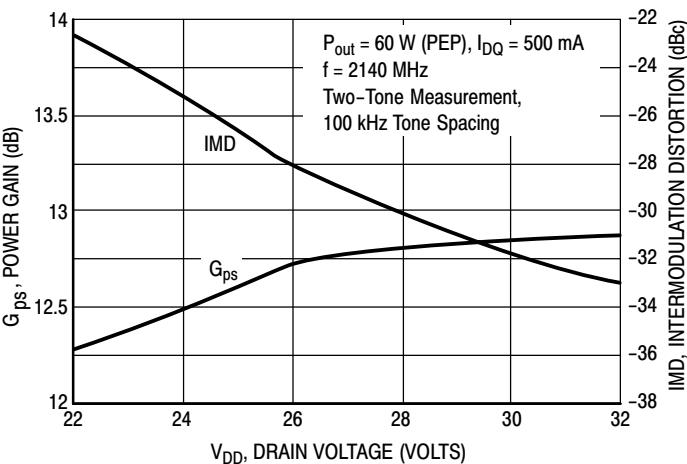
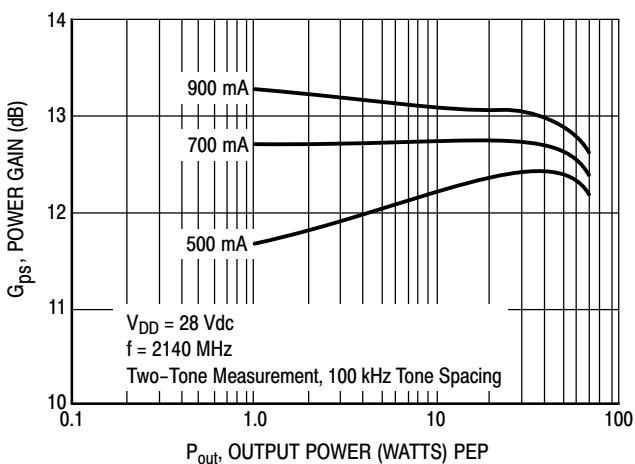
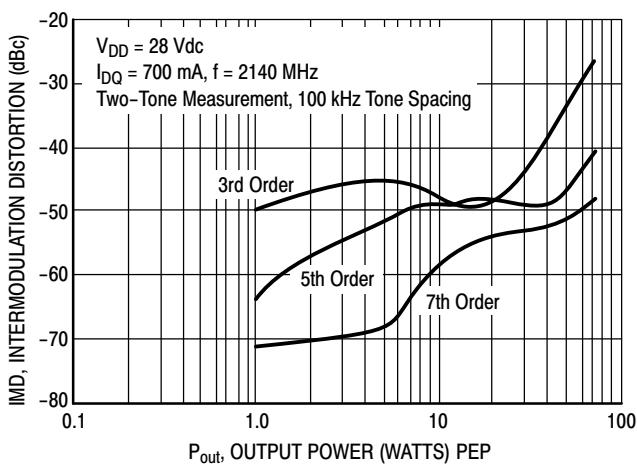
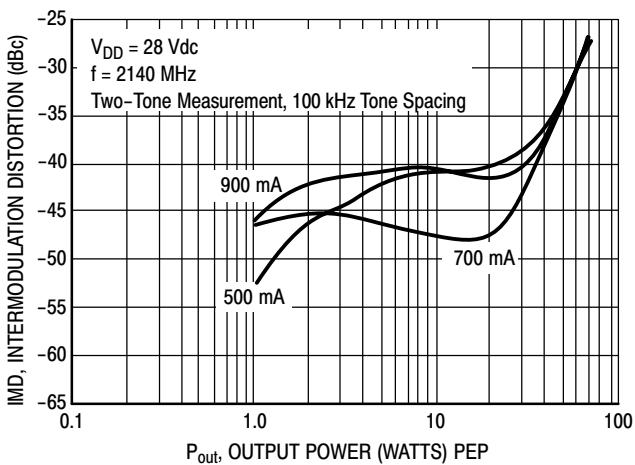
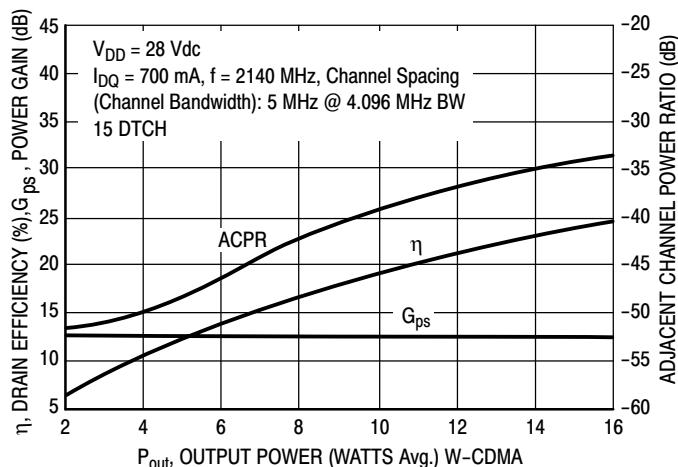
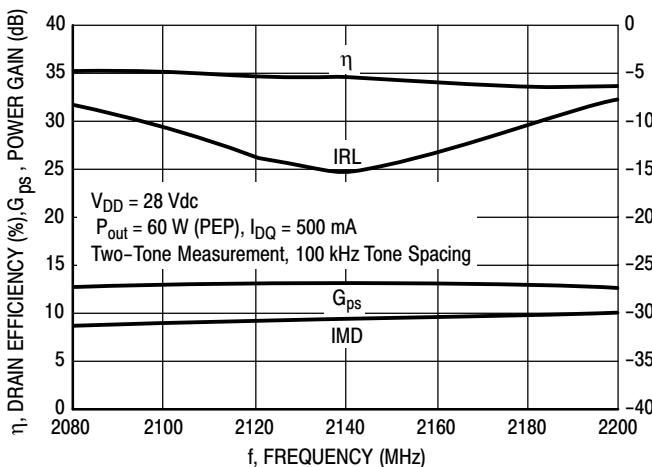
Figure 1. MRF21060 Test Circuit Schematic

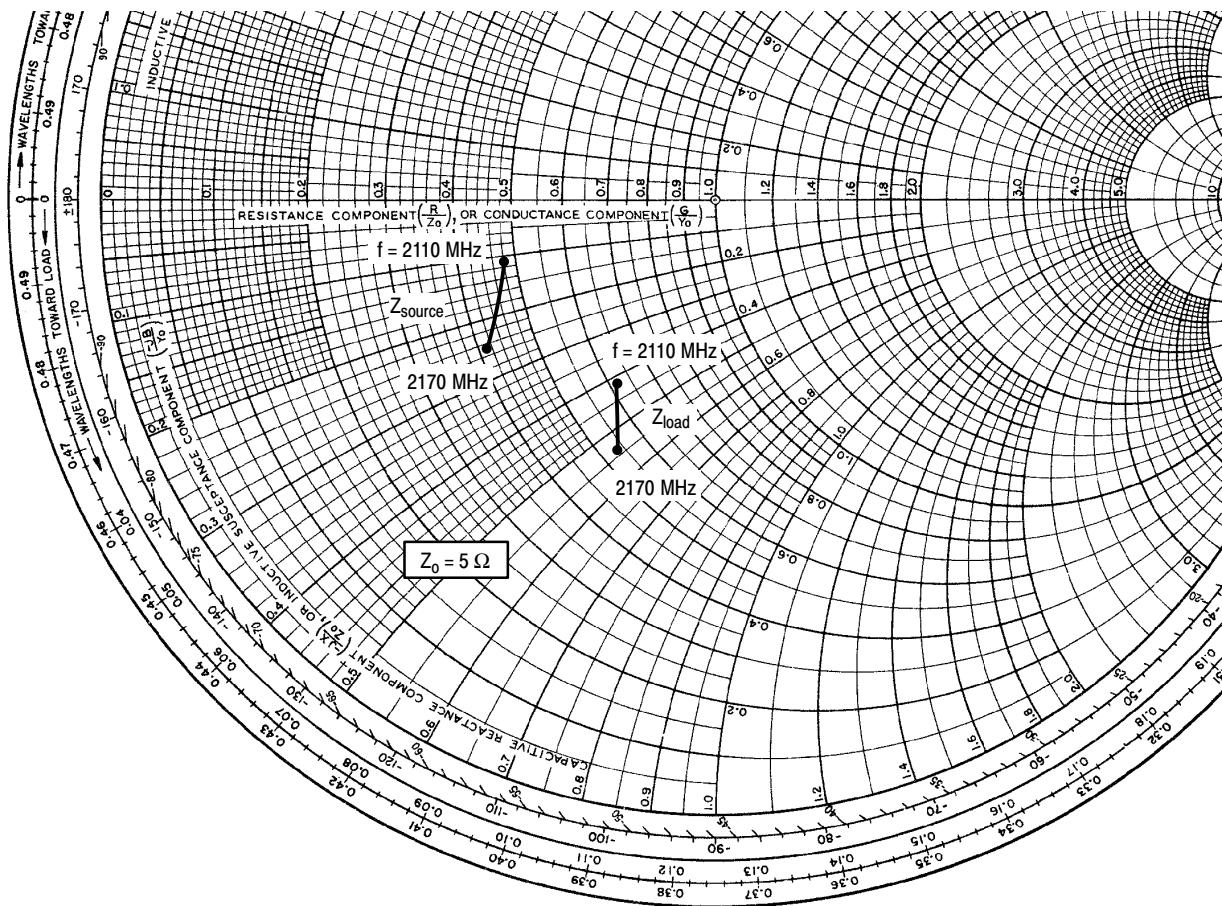


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Figure 2. MRF21060 Test Circuit Component Layout

TYPICAL CHARACTERISTICS





$V_{DD} = 28 \text{ V}$, $I_{DQ} = 500 \text{ mA}$, $P_{out} = 60 \text{ W PEP}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|------------|---------------------------------|-------------------------------|
| 2110 | $2.40 - j0.55$ | $3.07 - j2.05$ |
| 2140 | $2.26 - j0.87$ | $2.89 - j2.38$ |
| 2170 | $2.08 - j1.23$ | $2.66 - j2.71$ |

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

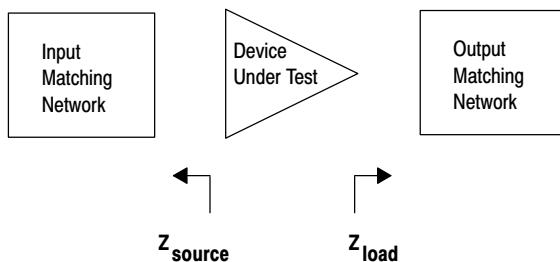
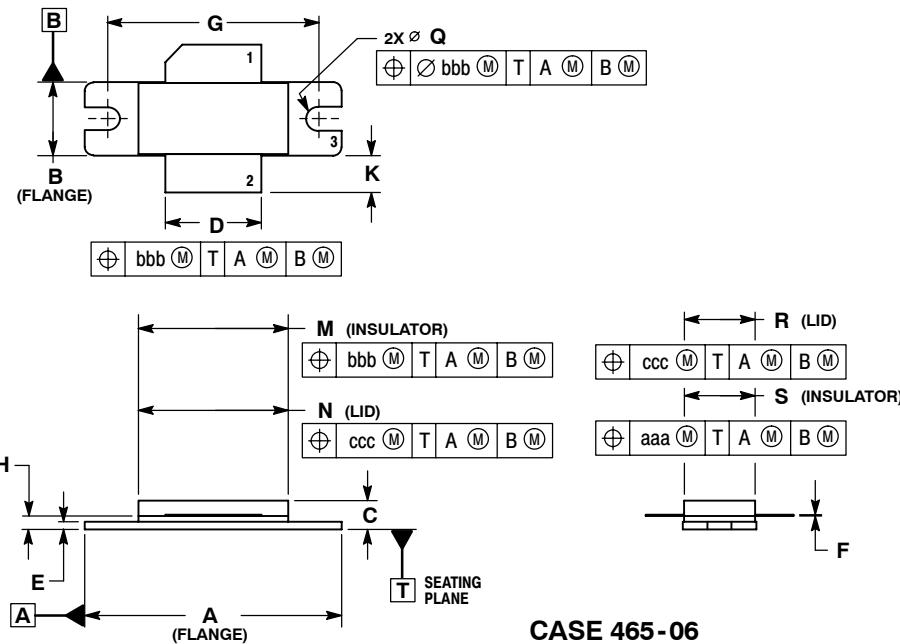
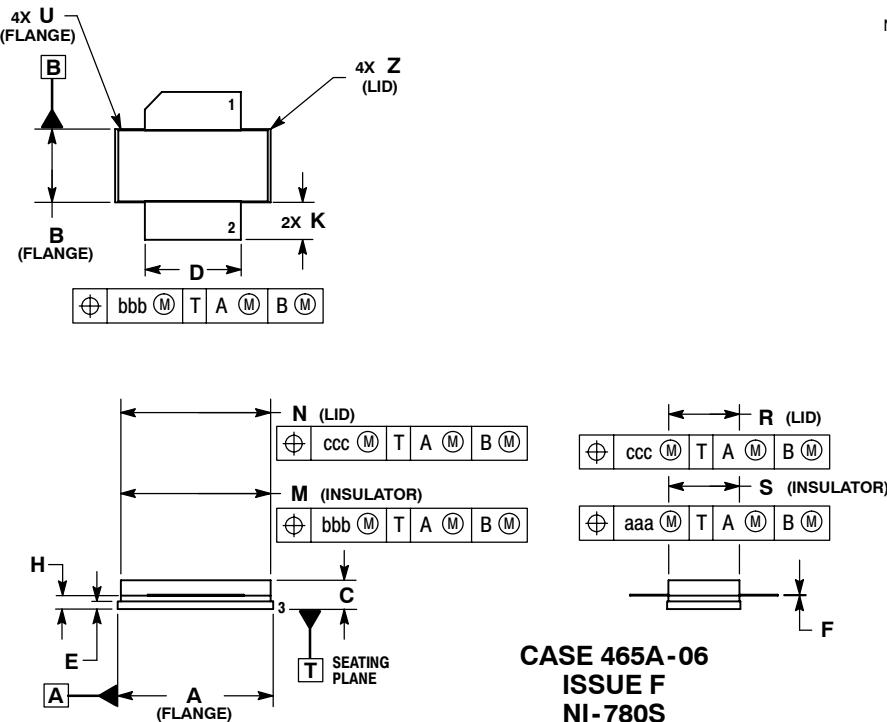


Figure 9. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS



**CASE 465-06
ISSUE F
NI-780
MRF21060R3**



**CASE 465A-06
ISSUE F
NI-780S
MRF21060SR3**

MRF21060R3 MRF21060SR3

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